

O 15 JUL 5 2002
U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

SHEET 1 OF 1

Form PTO 1449 (Modified)		ATTY DOCKET NO. 217050US0X CONT		SERIAL NO. 10/015,704	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Tatsuya ANDOH, et al.			
		FILING DATE 12/17/01		GROUP 1731	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUB CLASS FILING DATE IF APPROPRIATE
AA		5,972,197	10/26/99	ANDOH, et al.	
AB		6,264,819	07/24/01	ANDOH, et al.	
AC					
AD					
AE					
AF					
AG					
AH					
AI					
AJ					
AK					
AL					
AM					
AN					
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
AO					
AP					
AQ					
AR					
AS					
AT					
AU					
AV					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
	AW				
	AX				
	AY				
	AZ				
Examiner <i>ALW</i>		Date Considered <i>12/24/03</i>			

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Form PTO 1449 (Mod 1ec)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217050US0X CONT	SERIAL NO. 10/15704 NEW APPLICATION		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Tatsuya ANDOH, et al.			
		FILING DATE HEREWITH		GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
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	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	57-29690	02/17/82	JAPAN	YES	XX	
	AP	8-216290	08/27/96	JAPAN		XX	
	AQ	11-100780	04/13/99	JAPAN		XX	
	AR	WO 97/41295	11/06/97	WIPO			
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ				<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>SLW/LL</i>		Date Considered 10/24/03					
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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12/17/01
USPTO
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SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 217050US0XCONT	SERIAL NO. 10/015,704		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Tatsuya ANDOH, et al.			
		FILING DATE		GROUP			
		December 17, 2001		1731			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
BB	AA	4,012,280	03/15/77	H. H. HOLTON			
BB	AB	4,764,252	08/16/88	Y. SHIN, et al.			
BB	AC	5,871,663	02/16/99	W. T. TURNER			
BB	AD	5,624,545	04/29/97	J. LANDFORS, et al.			
	AE						
	AF						
	AG						
	AH						SEP 18 2002
	AI						
	AJ						TC 1700
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	WO 95/32331	11/30/95	WIPO	YES	NO	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Patent Abstracts of Japan, JP 7-189153, July 25, 1995					
	AX						
	AY						
	AZ	<input type="checkbox"/> Additional References sheet(s) attached 					
Examiner		Date Considered 06/24/03					

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